Search Notes

Applicati n/C ntr l No.	Applicant(s)/Patent und r Re xamination
10/002,999	LEUNG ET AL.
Examiner	Art Unit

Nerrie M. Zohn

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SEARCHED						
Class	Subclass	Date	Examiner			
707	104.1	12/13/2004	M			
705	5,7,8,14	12/13/2004	NS			
705	26,27,37	12/13/2004	M			
705	41,400	12/13/2004	M			
340	425.5	12/13/2004	MB			
342	457	12/13/2004	N3			
455	456.3	12/13/2004	NB			

INTERFERENCE SEARCHED					
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DATE	EXMR
12/13/2004	nz
12/16/2004	ns
12/13/2004	nz
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